

Notice of References Cited		Application/Control No. 10/525,204	Applicant(s)/Patent Under Reexamination TAKEYAMA ET AL.	
		Examiner ALTREV C. SYKES	Art Unit 4145	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0022575 A1	01-2003	Yoneda et al.	442/104
*	B	US-4,206,257	06-1980	Fukushima et al.	428/91
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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